

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/755,083	JENSEN ET AL.	
Examiner		Art Unit	1713	Page 1 of 2
Rip A. Lee				

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,388,017 B1	05-2002	McDaniel et al.	525/240
	B	US-5,786,291 A	07-1998	Speca et al.	502/104
	C	US-6,831,141 B2	12-2004	McDaniel et al.	526/129
	D	US-6,613,852 B2	09-2003	McDaniel et al.	526/160
	E	US-5,422,325 A	06-1995	Jejelowo et al.	502/104
	F	US-6,197,900 B1	03-2001	Seelert et al.	526/114
	G	US-6,583,227 B2	06-2003	Mehta et al.	525/240
	H	US-6,512,019 B1	01-2003	Agarwal et al.	521/134
	I	US-4,937,299	06-1990	Ewen et al.	526/119
	J	US-5,847,059 A	12-1998	Shamshoum et al.	526/116
	K	US-5,891,814 A	04-1999	Richeson et al.	442/401
	L	US-6,492,472 B2	12-2002	Lue et al.	526/114
	M	US-6,207,606 B1	03-2001	Lue et al.	502/113

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/755,083	JENSEN ET AL.	
Examiner		Art Unit		Page 2 of 2
Rip A. Lee		1713		

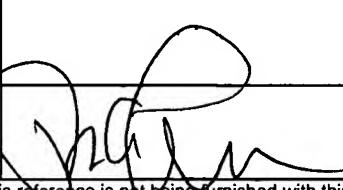
#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,541,413 B1	04-2003	Razavi et al.	502/152
	B	US-5,719,241 A	02-1998	Razavi et al.	526/119
	C	US-2003/0130443 A1	07-2003	Suhm et al.	526/65
	D	US-2003/0105237 A1	06-2003	WINTER et al.	525/240
	E	US-2003/0236364 A1	12-2003	McCullough et al.	526/68
	F	US-2004/0006186 A1	01-2004	Jensen et al.	526/133
	G	US-2004/0048990 A1	03-2004	Brinen et al.	526/114
	H	US-2002/0143123 A1	10-2002	Dekmezian et al.	526/119
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	 Dec 14, 2005

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.